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Application/Control No.	Applicant(s)/Patent under Reexamination	
10/516,424	KATO ET AL.	
Examiner	Art Unit	
Linh T. Nguyen	2627	

SEARCHED					
Class	Subclass	Date	Examiner		
III					

INTERFERENCE SEARCHED					
Subclass	Date	Examiner			
	Subclass	Subclass Date			

SEARCH NO (INCLUDING SEARCH	TES STRATEGY)
	DATE	EXMR
East searched.	10/2/2007	LN
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